

<b>Notice of References Cited</b>	Application/Control No. 10/790,784		Applicant(s)/Patent Under Reexamination MURAKAMI, NAOYA	
	Examiner MARCUS T. RILEY		Art Unit 2625	Page 1 of 1

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*	B	US-5,784,180 A	07-1998	Sakai et al.	358/501
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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